

<b>Notice of References Cited</b>	Application/Control No. 10/721,751	Applicant(s)/Patent Under Reexamination SHIINA ET AL.	
	Examiner Lee Lum	Art Unit 3611	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,390,230	05-2002	Shimizu et al.	180/444
	B	US-6,354,395	03-2002	Cheng et al.	180/444
	C	US-			
	D	US-6,561,306	05-2003	Watanabe et al.	180/444
	E	US-6,550,567	04-2003	Murakami et al.	180/444
	F	US-6,516,915	02-2003	Kurokawa et al.	180/444
	G	US-5,819,871	10-1998	Takaoka, Manabu	180/444
	H	US-5,738,183	04-1998	Nakajima et al.	180/444
	I	US-6,425,455	07-2002	Kurokawa et al.	180/444
	J	US-5,445,238	08-1995	Chikuma et al.	180/444
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.